Compliant with IEC 62474/ D9.00 Compliant to IEC 61249-2-21:2003

MICROCHIP  Semiconductor Device Type: ST (D8X) 016 TSSOP 4.4mm Matte Tin			Termination Base Alloy: Copper Alloy (Cu)			Package Homogeneous Materials: 8.1 Electronics (e.g. pc boards, displays)				JEDEC 97 Product Marking and/or Pkg. Labeling e3
	<u>,                                     </u>	"Contained In"	% I otal			22.50	(mg) Total	Mold Compound	% ot Total Weight	
Basic Substance	CAS Number	Sub-Component	Weight	mg/part	ppm	22.00		·	·	04.02
Silica, vitreous (or fused)	60676-86-0	Mold Compound	29.427	19.128	294,270		Silica, vitreous (or fused)		85.00	
Epoxy Resin	Trade Secret	Mold Compound	3.012	1.958	30,119		Epoxy Resin	Trade Secret	8.70	
Phenolic Resin Carbon Black	Trade Secret 1333-86-4	Mold Compound  Mold Compound	2.077 0.104	1.350 0.068	20,772 1.039		Phenolic Resin	Trade Secret	6.00	
	7440-50-8	Lead Frame	44.468		444.680		Carbon Black	1333-86-4 Total	0.30 <b>100.00</b>	<u>l</u>
Copper Nickel	7440-02-0	Lead Frame	1.186	28.904 0.771	11.859	30.35	( )= ( )	Lead Frame	% of Total Weight	46.69
					1	30.35	(mg) Total			46.69
Silver	7440-22-4	Lead Frame	0.779	0.507	7,793		Copper	7440-50-8	95.24	
Silicon	7440-21-3	Lead Frame	0.210	0.137	2,101		Nickel	7440-02-0	2.54	
Magnesium	7439-95-4	Lead Frame	0.047	0.030	467		Silver	7440-22-4	1.67	
Silver	7440-22-4	Die Attach	2.472	1.607	24,716		Silicon	7440-21-3	0.45	
Epoxy resin	Trade Secret	Die Attach	0.668	0.434	6,680		Magnesium	7439-95-4	0.10	
Metal oxide	Trade Secret	Die Attach	0.100	0.065	1,002			Total	100.00	
Gamma-butyrolactone	96-48-0	Die Attach	0.100	0.065	1,002	2.17	(mg) Total	Die Attach	% of Total Weight	3.34
Silicon	7440-21-3	Chip (Die)	12.340	8.021	123,400		Silver	7440-22-4	74.00	
Gold	7440-57-5	Wire Bond	0.610	0.397	6,100		Epoxy resin	Trade Secret	20.00	
Tin	7440-31-5	Plating on external leads (pins) - Matte Tin / annealed at 150°C for 1 hour	2.400	1.560	24,000		Metal oxide	Trade Secret	3.00	
		TOTALS:	100.000	65.000	1,000,000		Gamma-butyrolactone	96-48-0	3.00	
	0.0650	g Total Mass						Total	100.00	_
and 2002/53/EC (End-of-Life Vehicles (ELV) without ex	omply with EU Directives: emption (zero)	2002/95/EC (27 January 2003) & Directive 2011/65/EU (0	8 June 2011) aı	nd 2015/863/EU	J (31 March	8.02	Total (mg)	Chip (Die)	% of Total Weight	12.34
and 2002/53/EC (End-of-Life Vehicles (ELV) without ex pliance with the above EU Directives has been verified remical substance is absent from the list above, the ch	omply with EU Directives: emption (zero) via internal design control emical substance is NOT a ocument, there is no credi	s, supplier declarations, and /or analytical test data.  In intentional ingredient in the semiconductor device and ole reason to believe that the unavoidable impurity conce	l, to the best of	Microchip Tec	chnology	8.02	Total (mg)  Doped Silicon	Chip (Die) 7440-21-3 Total	% of Total Weight 100.00 100.00	12.34
and 2002/53/EC (End-of-Life Vehicles (ELV) without ex oliance with the above EU Directives has been verified nemical substance is absent from the list above, the ch porated's knowledge and belief as of the date of this di is not below the threshold of regulatory concern for an ing compounds used by Microchip meet the UL94 V0 fl ul.com/global/eng/pages/offerings/industries/chemica	omply with EU Directives: emption (zero) via internal design control emical substance is NOT a comment, there is no credi y regulatory scheme work ammability standard for p is/plastics/	s, supplier declarations, and /or analytical test data.  an intentional ingredient in the semiconductor device and ole reason to believe that the unavoidable impurity concerwide.  astics. You can access the UL iQTM family of databases to	I, to the best of ntration of the	Microchip Tec chemical subs report at	chnology stance, if	0.40		7440-21-3	100.00	
and 2002/53/EC (End-of-Life Vehicles (ELV) without ex oliance with the above EU Directives has been verified nemical substance is absent from the list above, the ch porated's knowledge and belief as of the date of this di is not below the threshold of regulatory concern for an ing compounds used by Microchip meet the UL94 V0 fl ul.com/global/eng/pages/offerings/industries/chemica	omply with EU Directives: emption (zero) via internal design control emical substance is NOT a comment, there is no credi y regulatory scheme work ammability standard for p is/plastics/	s, supplier declarations, and /or analytical test data.  In intentional ingredient in the semiconductor device and ole reason to believe that the unavoidable impurity concerwide.	I, to the best of ntration of the	Microchip Tec chemical subs report at	chnology stance, if		Doped Silicon	7440-21-3 Total Wire Bond 7440-57-5	100.00 100.00 % of Total Weight	
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and 2002/53/EC (End-of-Life Vehicles (ELV) without expliance with the above EU Directives has been verified the semical substance is absent from the list above, the choorated's knowledge and belief as of the date of this dis not below the threshold of regulatory concern for any ng compounds used by Microchip meet the UL94 V0 flul.com/global/eng/pages/offerings/industries/chemica rotective "tubes" in which the specific product is shipn "reels" may be made from PVC plastic.  The prochology Incorporated believes the information original packing materials is true and correct to the beleteness and accuracy of data in this form because it hantion is often protected from disclosure as trade secreted only as estimates of the average weight of these poants, metals, and non-metal materials contained within this provided by Microchip Technology Incorporated toes not provide any withing provided by Microchip Technology Incorporated tions, sales order acknowledgement, and invoices.	comply with EU Directives: emption (zero) via internal design control emical substance is NOT comment, there is no credi y regulatory scheme world ammability standard for p Is/plastics/ ped are made from polyvir in in this form concerning is st of its knowledge and be tas been compiled based of ets and some information arts and the average weig in silicon devices (silicon I arranty, express or implied and its subsidiaries are con- changes to Material Conter te users' reliance on the in	s, supplier declarations, and /or analytical test data.  an intentional ingredient in the semiconductor device and ole reason to believe that the unavoidable impurity concer-wide.  astics. You can access the UL iQTM family of databases to all chloride (PVC) plastic. "Window envelopes" used to be substances restricted by RoHS in Microchip Technology In lief, as of the date listed in this form. Microchip Technology in the ranges provided in Material Safety Data Sheets provimary not have been provided by subcontract assemblers at of anticipated significant toxic metals components. The C) in the finished parts.	I, to the best of ntration of the to obtain a test old the packing uncorporated's gy Incorporated by raw materiese estimates of tion. The exclusale. These are	Microchip Tec chemical subs report at g slip on the ou semiconducto d cannot guara taterial supplie al suppliers. Ir lo not include sive, limited pr p provided in M	chnology stance, if uter box and r devices in antee the ers. Supplier formation is trace levels	0.40	Doped Silicon  (mg) Total  Doped Gold	7440-21-3  Total  Wire Bond  7440-57-5  Total  Plating on external leads (pins) - Matte Tin / annealed at 150°C for 1	100.00 100.00 % of Total Weight 100.00	0.61

Au 11:12 AM : 8/17/2015